## **COMPONENT SPECIFICATION**

版次:第1.2版 MAX ECHO

N SMD WIRE WOUND CHIP INDUCTOR COMPOSITE SPECIFICATION 1/10

HBWS-2520 SPEC# HBWS2520-SERIES

1. SCOPE

This specification applies to the HBWS-2520 series SMD Wound Chip Inductor.

2. STANDARD ATMOSPHERIC CONDITIONS

Unless otherwise specified the standard range of atmospheric conditions for making measurements and tests is as follows:

Ambient temperature :  $20\pm15^{\circ}$ C Relative humidity :  $65\pm20\%$ 

If there may be any doubt on the results, measurements shall be made within

the following limits:

Ambient temperature :  $25\pm5^{\circ}$ C Relative humidity :  $75\pm10^{\circ}$ 

3. RATINGS

PART NO.	INDUCTANCE	*Tolorongo	Q	DC RESISTANCE	Rated current	S.R.F
FARI NO.	(nH)	**Tolerance	Min (Frequency)	(Ω) Max	(mA)max	Min(MHz)
HBWS2520-3N3	3.3@100MHz	±0.2nH,±0.3nH	50 (1000MHz)	0.060	1000	6000
HBWS2520-3N9	3.9@100MHz	±0.2nH,±0.3nH	38 (1000MHz)	0.100	1000	5500
HBWS2520-6N8	6.8@100MHz	±0.2nH,±5%,±10%	50 (1000MHz)	0.060	1000	5500
HBWS2520-8N2	8.2@100MHz	±0.2nH,±5%,±10%	50 (1000MHz)	0.060	1000	5500
HBWS2520-10N	10@100MHz	±2%,±5%,±10%	50 (1000MHz)	0.080	1000	4300
HBWS2520-12N	12@100MHz	±2%,±5%,±10%	60 (500MHz)	0.080	1000	3600
HBWS2520-15N	15@100MHz	±2%,±5%,±10%	60 (500MHz)	0.080	1000	2700
HBWS2520-18N	18@100MHz	±2%,±5%,±10%	60 (350MHz)	0.100	1000	2700
HBWS2520-22N	22@100MHz	±2%,±5%,±10%	60 (350MHz)	0.100	1000	2500
HBWS2520-27N	27@100MHz	±2%,±5%,±10%	60 (350MHz)	0.100	1000	1800
HBWS2520-33N	33@100MHz	±2%,±5%,±10%	60 (350MHz)	0.100	1000	1700
HBWS2520-39N	39@100MHz	±2%,±5%,±10%	60 (350MHz)	0.100	1000	1500
HBWS2520-47N	47@100MHz	±2%,±5%,±10%	60 (350MHz)	0.100	1000	1500
HBWS2520-56N	56@100MHz	±2%,±5%,±10%	60 (350MHz)	0.120	1000	1350
HBWS2520-68N	68@100MHz	±2%,±5%,±10%	60 (350MHz)	0.150	1000	1300
HBWS2520-82N	82@100MHz	±2%,±5%,±10%	60 (350MHz)	0.180	1000	1100
HBWS2520-R10	100@100MHz	±2%,±5%,±10%	60 (350MHz)	0.180	1000	1100
HBWS2520-R12	120@25.2MHz	±2%,±5%,±10%	45 (100MHz)	0.200	800	950
HBWS2520-R15	150@25.2MHz	±2%,±5%,±10%	45 (100MHz)	0.220	800	880
HBWS2520-R18	180@25.2MHz	±2%,±5%,±10%	45 (100MHz)	0.330	800	800
HBWS2520-R22	220@25.2MHz	±2%,±5%,±10%	45 (100MHz)	0.450	800	730
HBWS2520-R27	270@25.2MHz	±2%,±5%,±10%	45 (100MHz)	0.750	600	650
HBWS2520-R33	330@25.2MHz	±2%,±5%,±10%	45 (100MHz)	0.900	500	570
HBWS2520-R39	390@25.2MHz	±2%,±5%,±10%	45 (100MHz)	1.060	470	530

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版次:第1.2版 MAX ECHO SMD WIRE WOUND CHIP INDUCTOR COMPOSITE SPECIFICATION A M HBWS-2520 SPEC# HBWS2520-SERIES Е INDUCTANCE DC RESISTANCE Rated current S.R.F Q PART NO. ★Tolerance (nH) Min (Frequency)  $(\Omega)$  Max (mA)max Min(MHz) HBWS2520-R47 470@25.2MHz ±2%,±5%,±10% 45 (100MHz) 1.17 420 480 HBWS2520-R56 560@25.2MHz ±2%,±5%,±10% 45 (100MHz) 1.5 310 430 HBWS2520-R68 680@25.2MHz ±2%,±5%,±10% 45 (100MHz) 2.06 230 380 HBWS2520-R75 750@25.2MHz ±2%,±5%,±10% 45 (100MHz) 2.2 200 360 HBWS2520-R82 820@25.2MHz ±2%,±5%,±10% 45 (100MHz) 2.3 180 350 HBWS2520-R91 910@25.2MHz ±2%,±5%,±10% 45 (100MHz) 3.18 150 330 HBWS2520-1R0 000@25.2MH ±2%,±5%,±10% 35 (50MHz) 3.3 120 310

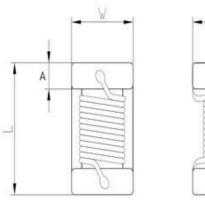
 <sup>★</sup> B:±0.2nH S:±0.3nH K:±10% J:±5% G:±2%

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N A	SMD WIRE WOUND CHIP INDUCTOR	COMPONI	3/	
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4. DIMENSION



OPERATING TEMP. RANGE:  $-40^{\circ}$ C ~  $+125^{\circ}$ C STORAGE TEMP. RANGE:  $-10^{\circ}$ C  $\sim +40^{\circ}$ C

~				
TYPE	L	W	T	A
HBWS-2520	2.60±0.20	2.15±0.20	1.80±0.20	0.4~0.6
	(.102±.008)	(.085±.008)	(.071±.008)	(.016±.024)

5. The place of origin: Taichung, Taiwan

HISTORY	DATE		REVISION	SIGN.	SIGN.
PLANNED BY	CHECKED BY	APPROVED BY		ede a sel de	
Marco	LUN	Tina Hsu	<b>€</b> 5.5	選文件中 發行章	<i>(</i> 3)

# MAX ECHO 鈺 鎧 科 技 股 份 有 限 公 司 規 格 標 準 書

## **COMPONENT SPECIFICATION**

版次:第1.2版 MAX ECHO

Name

SMD WIRE WOUND CHIP INDUCTOR | COMPONENT SPECIFICATION HBWS-2520

SPEC# HBWS2520-SERIES

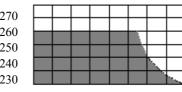
## **Reflow soldering conditions**

Pre – heating should be in such a way that the temperature difference between solder and ceramic surface is limited to 150°C max. Also cooling into solvent after soldering should be in such a way that the temperature difference is limited to 100°C max.

Insufficient pre—heating may cause cracks on the ceramic, resulting in the deterioration of product

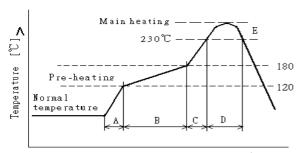
Products should be soldered within the following allowable range indicated by the slanted line. The excessive soldering conditions may cause the corrosion of the electrode, when soldering is repeated, allowable time is the accumulated time.





0 10 20 30 40 50 60 70

#### Temperature Profile



A	Slope of temp. rise	1 to 5	°C/sec
В	Heat time	50 to 150	sec
ь	Heat temperature	120 to 180	$^{\circ}\!\mathbb{C}$
С	Slope of temp. rise	1 to 5	°C/sec
D	Time over 230°C	90~120	sec
Е	Peak temperature	255~260	$^{\circ}\!\mathbb{C}$
E	Peak hold time	10 max.	sec
	No. of mounting	3	times

Time [sec] (Melting area of solder)

#### Reworking with soldering iron

<u>,</u>	
Preheating	150°C, 1 minute
Tip temperature	280°C max.
Soldering time	3 seconds max.
Soldering iron output	30w max.
End of soldering iron	f3mm max.

Reworking should be limited to only one time.

Note: Do not directly touch the products with the tip of the soldering iron in order to prevent the crack on the ferrite material due to the thermal shock.

#### **Solder Volume**

Solder shall be used not to be exceed the upper limits as shown below.

Upper Limit Recommendable

When the amount of solder volume increased, mechanical stress increased as well. Exceeding amount of solder volume may lead to failure of mechanical or electronical characteristics.

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## **Mechanical Characteristics**

ITEM	CONDITION	SPECIFICATION
Inductance and Tolerance	Measuring Frequency :  As shown in Product Table	Within Specified Tolerance
Quality Factor	Measuring Temperature: +25 °C	
Insulation Resistance	Measured at 100V DC between inductor terminals and center of case.	1000 mega ohms minimum

## **Electrical Characteristics**

ITEM	CONDITION	SPECIFICATION
Component Adhesion	The component shall be reflow	0402 series - ≥350g
(Push Test)	soldered onto a P. C. Board	0603 series - ≥1.0Kg
	( $240  ^{\circ}\text{C} \pm 5  ^{\circ}\text{C}$ for 20 seconds ).	Other series - 2012 ~ 3225
	Then a dynometer force gauge shall	Minimum 1Kg for Pd/Ag
	be applied to any side of the	termination and 2Kg for Mo/Mn
	component.	
Drop Test	The inductor shall be dropped	Change In Inductance:
	two times on the concrete floor	No more than 5%
	or the vinyl tile from 1M naturally.	
Thermal Shock Test	Each cycle shall consist of 30 minutes at	Change In Q:
	-40 °C followed by 30 minutes at +85 °C	No more than 10%
	with a 20-second maximum transition	
	time between temperature extremes.	Change In Appearance:
	Test duration is 10 cycles.	Without distinct damage
Substrate Bending Test	_	9 1
	shall meet specifications.	substrate, bend the substrate by 3mm
		hold for 10s and then return.
		Soldering shall be done in
		accordance with the recommended
		PC board pattern and reflow soldering.
		soldering.
		unit : mm

# **COMPONENT SPECIFICATION**

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## **Endurance Characteristics**

ITEM	CONDITION	SPECIFICATION
Solderability	Dip pads in flux and dip in solder pot	A minimum of 80% of the metalized
	containing lead free solder at	area must be covered with solder.
	$240 ^{\circ}\text{C} \pm 5^{\circ}\text{C}$ for 5 seconds.	
Resistance to Soldering Hea	Dip the components into flux and dip	Change In Inductance:
	into solder pot containing lead free solder	No more than 5%
	at 260 °C $\pm$ 5 °C for 5 $\pm$ 2 seconds.	
Vibration (Random)	Inductors shall be randomly vibrated at	Change In Q:No more than 10%
	amplitude of 1.5mm and frequency of	
	10 - 55 Hz: 0.04 G / Hz for a minimum	
	of 15 minutes per axis for each of the	
	three axes.	
Cold Temperature Storage	Inductors shall be stored at temperature	Change In Appearance :
	of -40 °C $\pm$ 2 °C for 1000hrs (+ 48 -0hrs.)	Without distinct damage
	Then inductors shall be subjected to	
	standard atmospheric conditions for 1 hour	
	After that, measurement shall be made.	
High Temperature Storage	Inductors shall be stored at temperature	
	of $85 ^{\circ}\text{C} \pm 2 ^{\circ}\text{C}$ for $1000 \text{hrs} (+48 - 0 \text{hrs.})$	
	Then inductors shall be subjected to	
	standard atmospheric conditions	
	for 1 hour.	
	After that, measurement shall be made.	
Moisture Resistance		Inductors shall not have a shorted
	45 °C at 90 - 95 R. H. for 1000 hours.	or open winding.
	Then inductors are to be tested after	
	2 hours at room temperature.	
High Temperature	Inductors shall be stored in the chamber	
with Loaded	at +85 °C for 1000 hours with rated	
	current applied. Inductors shall be tested	
	at the beginning of test at 500 hours and	
	1000 hours.	
	Then inductors are to be tested after	
	1 hour at room temperature.	

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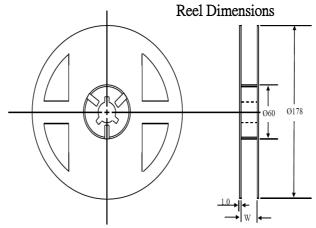
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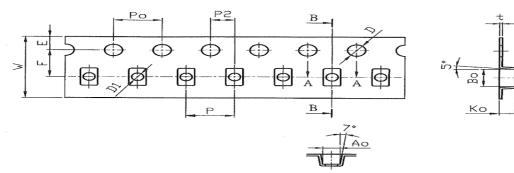
# **Packaging Information**

TYPE	PCS / REEL
HBWS 1005	10,000
HBWS 1608	3,000
HBWS 2012	2,000
HBWS 2520	2,000



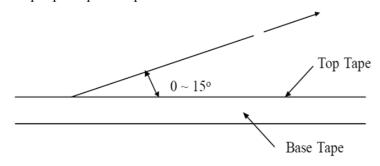
Tane Dimensions (unitem/m)

14														
Size	CARRIER													
Size	Ao	Во	Ko	t	D	D1		Е	F	P	Po	P2	W	Unit
1005	0.62±0.05	1.12±0.05	NA	0.60±0.05	1.55±0.05	NA		1.75±0.10	3.50±0.05	2.00±0.05	4.00±0.10	NA	8.00±0.10	mm
1608	1.40±0.1	1.90±0.1	1.15±0.1	0.23±0.05	1.50+0.10/-0.00	0.60±0.10		1.75±0.10	3.50±0.05	4.00±0.10	4.00±0.10	2.00±0.05	8.00±0.10	mm
2012	1.42±0.1	2.26±0.1	1.30±0.1	0.23±0.05	1.50+0.10/-0.00	0.70±0.10		1.75±0.10	3.50±0.05	4.00±0.10	4.00±0.10	2.00±0.05	8.00±0.10	mm
2520	2.20±0.1	2.83±0.1	1.75±0.1	0.22±0.05	1.50+0.10/-0.00	1.00±0.10		1.75±0.10	3.50±0.05	4.00±0.10	4.00±0.10	2.00±0.05	8.00±0.10	mm



10p 1ape Strengtn

The top tape requires a peel-off force of 0.2 to 0.7N in the direction of the arrow as illustrated below.

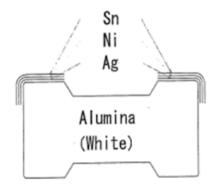


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# Ingredient of terminals electrode.



# Ceramic Type Sn Nickel Ag

## **Operation Environment**

Do not use this product under the following environmental conditions, on deterioration of performance, such as insulation resistance may result from the use.

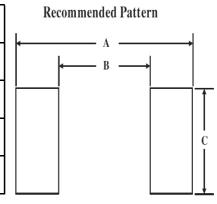
- 1. In corrosive gases (acidic gases, alkaline gases, chlorine, sulfur gases, organic gases and etc.)
- 2. In the atmosphere where liquid such as organic solvent, may splash on the products.

## **Delivery**

Care should be taken when transporting or handling product to avoid excessive vibration or mechanical shock.

## Pattern Dimensions (unit:m/m)

Metric (EIA)	A mm	B mm	C mm
Metric (EIA)	(inches)	(inches)	(inches)
1005 (0402)	1.20	0.45	0.65
1003 (0402)	(0.047)	(0.018)	(0.026)
1608 (0603)	1.90	0.65	1.00
1008 (0003)	(0.075)	(0.026)	(0.039)
2012 (0805)	2.60	0.75	1.30
2012 (0803)	(0.102)	(0.030)	(0.051)
2520 (1008)	3.00	1.20	2.20
2320 (1008)	(0.118)	(0.047)	(0.087)



## COMPONENT SPECIFICATION

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SMD WIRE WOUND CHIP INDUCTOR COMPONENT SPECIFICATION HBWS-2520 SPEC# HBWS2520-SERIES

Peeling Strength Of Cover Tape
Cover tape (10g~100g)

165°~180°

Test condition

1. peel angle: 165°~180° vs carrier tape

2. peel speed: 300mm/min

#### **Packaging**

1) Tape & Reel packaging in component specification 5/8

2) Reel and a bag of desiccant shall be packed in Nylon or plastic bag

3) Maximum of 5 reels shall be packaged in a inner box

4) Maximum of 6 inner box shall be packaged in a outer box

#### **Reel Label**

Producing the goods label needs to indicate (1) Pb Free (2) RoHS Compliant

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Storage

1. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to high humidity. Packages must be stored at 40°C or less and 70% RH or less.

HBWS-2520

- 2. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to dust or harmful gas (hydrogen chloride, sulfurous acid gas or hydrogen sulfide).
- 3. Packaging material may be deformed if packages are stored where they are exposed to heat or direct sun—light.
- 4. Minimum packages, such as polyvinyl heat—seal packages shall not be opened until just before they are used. If opened, use the reels as soon as possible.
- 5. Solderability specified in component specification 4/8 shall be for 12 months from the date of delivery on condition that they are stored at the environment specified clause 13-1 & 13-2.

For those parts which passed more than 12 months shall be checked solderability before it is used.

## **Quality System**

- ISO/IATF16949
- IECQ QC 080000